

SCAS416P-MARCH 1994-REVISED NOVEMBER 2005

#### FEATURES

- Member of the Texas Instruments Widebus™ Family
- Max t<sub>nd</sub> of 5.8 ns at 3.3 V
- ±24-mA Output Drive at 3.3 V
- Control Inputs VIH/VIL Levels Are Referenced to V<sub>CCA</sub> Voltage
- Latch-Up Performance Exceeds 250 mA Per JESD 17

NOTE: New and improved versions of the SN74ALVC164245 are available. The new part numbers are SN74LVC16T245 and SN74LVCH16T245 and should be considered for new designs.

## DESCRIPTION/ORDERING INFORMATION

This 16-bit (dual-octal) noninverting bus transceiver contains two separate supply rails. B port has  $V_{\text{CCB}},$ which is set to operate at 3.3 V and 5 V. A port has V<sub>CCA</sub>, which is set to operate at 2.5 V and 3.3 V. This allows for translation from a 2.5-V to a 3.3-V environment, and vice versa, or from a 3.3-V to a 5-V environment, and vice versa.

The SN74ALVC164245 is designed for asynchronous communication between data buses. The control circuitry (1DIR, 2DIR, 1OE, and 2OE) is powered by V<sub>CCA</sub>.

To ensure the high-impedance state during power up or power down, the output-enable  $(\overline{OE})$  input should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

	(TOP VI	EW)	
1DIR [ 1B1 [ 1B2 [ GND [ 1B3 [ 1B4 [ (3.3 V, 5 V) V <sub>CCB</sub> [ 1B5 [ 1B6 [ GND [ 1B7 [ 1B8 [ 2B1 [ 2B2 [ GND [	1 2 3 4 5 6 7 8 9 10 11 12 13 14	48 47 46 45 44 43 42 41 40 39 38 37 36 35	] 10E ] 1A1 ] 1A2 ] GND ] 1A3 ] 1A4 ] V <sub>CCA</sub> (2.5 V, 3.3 V) ] 1A5 ] 1A6 ] GND ] 1A7 ] 1A8 ] 2A1 ] 2A2 ] GND
2B2 [	14 15 16 17 18 19 20 21 22	<ol> <li>35</li> <li>34</li> <li>33</li> <li>32</li> <li>31</li> <li>30</li> <li>29</li> <li>28</li> <li>27</li> <li>26</li> </ol>	2A2

DGG OR DL PACKAGE

T <sub>A</sub>	PACKA	GE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	FBGA – GRD	Tone and real	74ALVC164245GRDR	- VC4245
	FBGA – ZRD (Pb-free)	Tape and reel	74ALVC164245ZRDR	VC4245
		Tube of 25	SN74ALVC164245DL	
	SSOP – DL	Deal of 4000	SN74ALVC164245DLR	ALVC164245
		Reel of 1000	74ALVC164245DLRG4	
–40°C to 85°C		Reel of 2000	SN74ALVC164245DGGR	
	TOCOD DOC	Reel 01 2000	74ALVC164245DGGRG4	
	TSSOP – DGG	Deal of 050	SN74ALVC164245DGGT	ALVC164245
		Reel of 250	74ALVC164245DGGTE4	
	VFBGA – GQL	Deal of 4000	SN74ALVC164245KR	V04045
	VFBGA – ZQL (Pb-free)	Reel of 1000	74ALVC164245ZQLR	- VC4245

#### **ORDERING INFORMATION**

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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## **DESCRIPTION/ORDERING INFORMATION (CONTINUED)**

The logic levels of the direction-control (DIR) input and the output-enable ( $\overline{OE}$ ) input activate either the B-port outputs or the A-port outputs or place both output ports into the high-impedance mode. The device transmits data from the A bus to the B bus when the B-port outputs are activated, and from the B bus to the A bus when the A-port outputs are activated. The input circuitry on both A and B ports always is active and must have a logic HIGH or LOW level applied to prevent excess I<sub>CC</sub> and I<sub>CCZ</sub>.

G	GQL OR ZQL PACKAGE (TOP VIEW)							
	1 2 3 4 5 6							
A	000000							
в	000000							
С	000000							
D	000000							
Е	00 00							
F	00 00							
G	000000							
н	000000							
J	000000							
к	000000							

### TERMINAL ASSIGNMENTS<sup>(1)</sup> (56-Ball GQL/ZQL Package)

	1	2	3	4	5	6
Α	1DIR	NC	NC	NC	NC	1 <del>0E</del>
в	1B2	1B1	GND	GND	1A1	1A2
С	1B4	1B3	V <sub>CCB</sub>	V <sub>CCA</sub>	1A3	1A4
D	1B6	1B5	GND	GND	1A5	1A6
Е	1B8	1B7			1A7	1A8
F	2B1	2B2			2A2	2A1
G	2B3	2B4	GND	GND	2A4	2A3
н	2B5	2B6	V <sub>CCB</sub>	V <sub>CCA</sub>	2A6	2A5
J	2B7	2B8	GND	GND	2A8	2A7
κ	2DIR	NC	NC	NC	NC	2 <mark>0E</mark>

(1) NC - No internal connection

#### TERMINAL ASSIGNMENTS<sup>(1)</sup> (54-Ball GRD/ZRD Package)

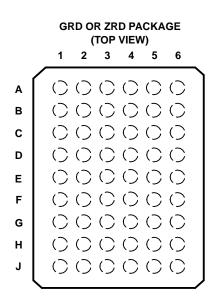
	1	2	3	4	5	6
Α	1B1	NC	1DIR	1 <del>0E</del>	NC	1A1
В	1B3	1B2	NC	NC	1A2	1A3
С	1B5	1B4	V <sub>CCB</sub>	V <sub>CCA</sub>	1A4	1A5
D	1B7	1B6	GND	GND	1A6	1A7
Е	2B1	1B8	GND	GND	1A8	2A1
F	2B3	2B2	GND	GND	2A2	2A3
G	2B5	2B4	V <sub>CCB</sub>	V <sub>CCA</sub>	2A4	2A5
н	2B7	2B6	NC	NC	2A6	2A7
J	2B8	NC	2DIR	2 <mark>0E</mark>	NC	2A8

(1) NC – No internal connection

#### FUNCTION TABLE<sup>(1)</sup> (EACH 8-BIT SECTION)

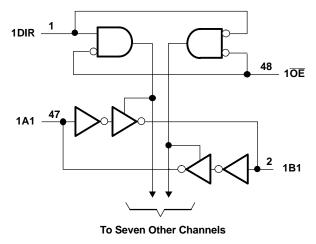
CONTRO	CONTROL INPUTS		IRCUITS	OPERATION
OE	DIR	A PORT	<b>B PORT</b>	OPERATION
L	L	Enabled	Hi-Z	B data to A bus
L	Н	Hi-Z	Enabled	A data to B bus
Н	Х	Hi-Z	Hi-Z	Isolation

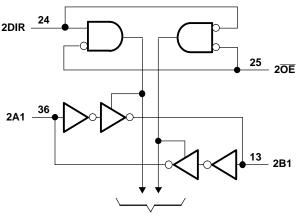
(1) Input circuits of the data I/Os always are active.



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#### LOGIC DIAGRAM (POSITIVE LOGIC)





**To Seven Other Channels** 

## Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range for V<sub>CCB</sub> at 5 V and V<sub>CCA</sub> at 3.3 V (unless otherwise noted)

			MIN	MAX	UNIT
V	Supply voltage renge	V <sub>CCA</sub>	-0.5	4.6	V
V <sub>CC</sub>	Supply voltage range	V <sub>CCB</sub>	-0.5	6	v
		Except I/O ports <sup>(2)</sup>	-0.5	6	
VI		I/O port A <sup>(3)</sup>	-0.5	V <sub>CCA</sub> + 0.5	V
		I/O port B <sup>(2)</sup>	-0.5	V <sub>CCB</sub> + 0.5	
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>0</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current			±50	mA
	Continuous current through each $V_{CC}$ or	GND		±100	mA
		DGG package		70	
0	Deckage thermal impedance (4)	DL package		63	°C/W
$\theta_{JA}$	Package thermal impedance <sup>(4)</sup>	GQL/ZQL package		42	
		GRD/ZRD package		36	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) This value is limited to 6 V maximum.

(3) This value is limited to 4.6 V maximum.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.



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## **Recommended Operating Conditions**<sup>(1)</sup>

for V<sub>CCB</sub> at 3.3 V and 5 V

				MIN	MAX	UNIT
V <sub>CCB</sub>	Supply voltage			3	5.5	V
V <sub>IH</sub>	High-level input voltage			2		V
V	Low-level input voltage	$V_{CCB} = 3 V \text{ to } 3.6 V$			0.7	V
V <sub>IL</sub>		$V_{CCB}$ = 4.5 V to 5.5 V			0.8	v
V <sub>IB</sub>	Input voltage			0	V <sub>CCB</sub>	V
V <sub>OB</sub>	Output voltage			0	$V_{CCB}$	V
I <sub>OH</sub>	High-level output current				-24	mA
I <sub>OL</sub>	Low-level output current				24	mA
$\Delta t/\Delta v$	Input transition rise or fall rat	e			10	ns/V
T <sub>A</sub>	Operating free-air temperatu	re		-40	85	°C

 All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

## **Recommended Operating Conditions**<sup>(1)</sup>

for  $V_{\rm CCA}$  at 2.5 V and 3.3 V

			MIN	MAX	UNIT
$V_{CCA}$	Supply voltage		2.3	3.6	V
V		V <sub>CCA</sub> = 2.3 V to 2.7 V	1.7		V
V <sub>IH</sub>	High-level input voltage	$V_{CCA} = 3 V \text{ to } 3.6 V$	2		v
V		V <sub>CCA</sub> = 2.3 V to 2.7 V		0.7	V
12	Low-level input voltage	$V_{CCA} = 3 V \text{ to } 3.6 V$		0.8	v
VIA	Input voltage		0	V <sub>CCA</sub>	V
V <sub>OA</sub>	Output voltage		0	$V_{CCA}$	V
	Lieb level evitevit evinent	V <sub>CCA</sub> = 2.3 V		-18	
I <sub>OH</sub>	High-level output current	V <sub>CCA</sub> = 3 V		-24	mA
		V <sub>CCA</sub> = 2.3 V		18	~ ^
I <sub>OL</sub>	Low-level output current	V <sub>CCA</sub> = 3 V		24	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	· · ·		10	ns/V
T <sub>A</sub>	Operating free-air temperature		-40	85	°C

 All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

### **Electrical Characteristics**

over recommended operating free-air temperature range for V<sub>CCA</sub> = 2.7 V to 3.6 V and V<sub>CCB</sub> = 4.5 V to 5.5 V (unless otherwise noted)

P	ARAMETER	TEST CONDITIONS	V <sub>CCA</sub>	V <sub>CCB</sub>	MIN	<b>TYP</b> <sup>(1)</sup>	MAX	UNIT
		I <sub>OH</sub> = -100 μA	2.7 V to 3.6 V		$V_{CC} - 0.2$			
M	D to A	1. 12 m	2.7 V		2.2			
	B to A	$I_{OH} = -12 \text{ mA}$	3 V		2.4			
		$I_{OH} = -24 \text{ mA}$	3 V		2			V
V <sub>OH</sub>		L _ 100 ··· A		4.5 V	4.3			v
	A to B	I <sub>OH</sub> = −100 μA		5.5 V	5.3			
	ALOB	1 24 m		4.5 V	3.7			
		$I_{OH} = -24 \text{ mA}$		5.5 V	4.7			
	B to A	I <sub>OL</sub> = 100 μA	2.7 V to 3.6 V				0.2	
		I <sub>OL</sub> = 12 mA	2.7 V				0.4	
V <sub>OL</sub>		I <sub>OL</sub> = 24 mA	3 V				0.55	V
	A to D	I <sub>OL</sub> = 100 μA		4.5 V to 5.5 V			0.2	
	A to B	I <sub>OL</sub> = 24 mA		4.5 V to 5.5 V			0.55	
I <sub>I</sub>	Control inputs	$V_{I} = V_{CCA}/V_{CCB}$ or GND	3.6 V	5.5 V			±5	μA
$I_{OZ}^{(2)}$	A or B port	$V_{O} = V_{CCA}/V_{CCB}$ or GND	3.6 V	5.5 V			±10	μΑ
I <sub>CC</sub>		$V_{I} = V_{CCA}/V_{CCB}$ or GND, $I_{O} = 0$	3.6 V	5.5 V			40	μA
$\Delta I_{CC}$	3)	One input at $V_{CCA}/V_{CCB} - 0.6 V$ , Other inputs at $V_{CCA}/V_{CCB}$ or GND	3 V to 3.6 V	4.5 V to 5.5 V			750	μΑ
Ci	Control inputs	$V_{I} = V_{CCA}/V_{CCB}$ or GND	3.3 V	5 V		6.5		pF
Cio	A or B port	$V_{O} = V_{CCA}/V_{CCB}$ or GND	3.3 V	3.3 V		8.5		pF

(1)

(2)

Typical values are measured at  $V_{CCA} = 3.3 \text{ V}$  and  $V_{CCB} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . For I/O ports, the parameter I<sub>OZ</sub> includes the input leakage current. This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than at 0 or the associated (3)V<sub>CC</sub>.

#### **Electrical Characteristics**

over recommended operating free-air temperature range for V<sub>CCA</sub> = 2.3 V to 2.7 V and V<sub>CCB</sub> = 3 V to 3.6 V (unless otherwise noted)

P	ARAMETER	TEST CONDITIONS	V <sub>CCA</sub>	V <sub>CCB</sub>	MIN	MAX	UNIT
		I <sub>OH</sub> = -100 μA	2.3 V to 2.7 V	3 V to 3.6 V	$V_{CCA} - 0.2$		
	B to A	$I_{OH} = -8 \text{ mA}$	2.3 V	3 V to 3.6 V	1.7		
V <sub>OH</sub>		$I_{OH} = -12 \text{ mA}$	2.7 V	3 V to 3.6 V	1.8		V
	A to D	I <sub>OH</sub> = -100 μA	2.3 V to 2.7 V	3 V to 3.6 V	V <sub>CCB</sub> - 0.2		
	A to B	I <sub>OH</sub> = -18 mA	2.3 V to 2.7 V	3 V	2.2		
	B to A	I <sub>OL</sub> = 100 μA	2.3 V to 2.7 V	3 V to 3.6 V		0.2	
V		I <sub>OL</sub> = 12 mA	2.3 V	3 V to 3.6 V		0.6	V
V <sub>OL</sub>	A to B	I <sub>OL</sub> = 100 μA	2.3 V to 2.7 V	3 V to 3.6 V		0.2	v
	ALOB	I <sub>OL</sub> = 18 mA	2.3 V	3 V		0.55	
I <sub>I</sub>	Control inputs	$V_{I} = V_{CCA}/V_{CCB}$ or GND	2.3 V to 2.7 V	3 V to 3.6 V		±5	μA
$I_{OZ}^{(1)}$	A or B port	$V_{O} = V_{CCA}/V_{CCB}$ or GND	2.3 V to 2.7 V	3 V to 3.6 V		±10	μA
I <sub>CC</sub>		$V_{I} = V_{CCA}/V_{CCB}$ or GND, $I_{O} = 0$	2.3 V to 2.7 V	3 V to 3.6 V		20	μA
$\Delta I_{CC}^{(2)}$	?)	One input at $V_{CCA}/V_{CCB} - 0.6 V$ , Other inputs at $V_{CCA}/V_{CCB}$ or GND	2.3 V to 2.7 V	3 V to 3.6 V		750	μΑ

(1) For I/O ports, the parameter  $I_{\text{OZ}}$  includes the input leakage current.

This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than at 0 or the associated (2)  $V_{CC}$ .



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### **Switching Characteristics**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1 through Figure 4)

PARAMETER			V <sub>CCB</sub> = 3.3 V ± 0.3 V	V <sub>CCB</sub> = 5 \	/ $\pm$ 0.5 V	
	FROM (INPUT)	TO (OUTPUT)	V <sub>CCA</sub> = 2.5 V ± 0.2 V	V <sub>CCA</sub> = 2.7 V	$V_{CCA} = 3.3 V \\ \pm 0.3 V$	UNIT
			MIN MAX	MIN MAX	MIN MAX	
+	А	В	7.6	5.9	1 5.8	20
t <sub>pd</sub>	В	А	7.6	6.7	1.2 5.8	ns
t <sub>en</sub>	OE	В	11.5	9.3	1 8.9	ns
t <sub>dis</sub>	ŌĒ	В	10.5	9.2	2.1 9.5	ns
t <sub>en</sub>	ŌĒ	А	12.3	10.2	2 9.1	ns
t <sub>dis</sub>	ŌĒ	А	9.3	9	2.9 8.6	ns

# **Operating Characteristics**

 $T_A = 25^{\circ}C$ 

PARAMETER			TEST CONDITIONS	V <sub>CCB</sub> = 3.3 V V <sub>CCA</sub> = 2.5 V TYP	V <sub>CCB</sub> = 5 V V <sub>CCA</sub> = 3.3 V TYP	UNIT
	Power dissipation capacitance	Outputs enabled (B)		55	56	рF
C <sub>pd</sub>		Outputs disabled (B)	$C_{L} = 50 \text{ pF}, \text{ f} = 10 \text{ MHz}$	27	6	
		Outputs enabled (A)	C <sub>1</sub> = 50 pF, f = 10 MHz	118	56	
		Outputs disabled (A)	$C_{L} = 50 \text{ pr},  I = 10 \text{ MHz}$	58	6	

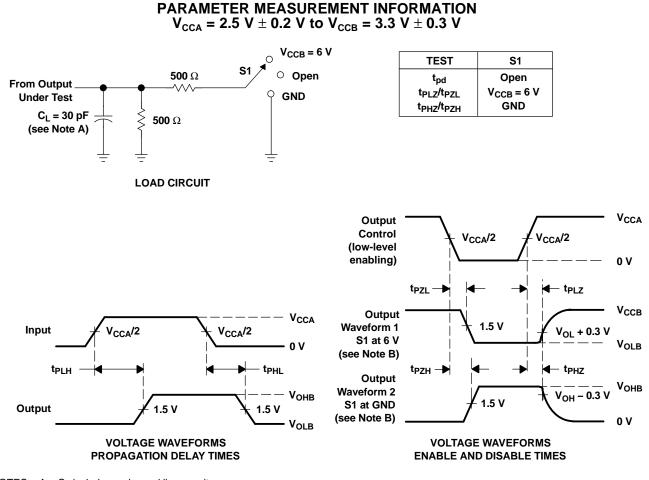
#### POWER-UP CONSIDERATIONS(1)

TI level-translation devices offer an opportunity for successful mixed-voltage signal design. A proper power-up sequence always should be followed to avoid excessive supply current, bus contention, oscillations, or other anomalies caused by improperly biased device pins. Take these precautions to guard against such power-up problems:

- 1. Connect ground before any supply voltage is applied.
- 2. Power up the control side of the device (V<sub>CCA</sub> for all four of these devices).
- 3. Tie  $\overline{OE}$  to V<sub>CCA</sub> with a pullup resistor so that it ramps with V<sub>CCA</sub>.
- 4. Depending on the direction of the data path, DIR can be high or low. If DIR high is needed (A data to B bus), ramp it with V<sub>CCA</sub>. Otherwise, keep DIR low.
- (1) Refer to the TI application report, Texas Instruments Voltage-Level-Translation Devices, literature number SCEA021.

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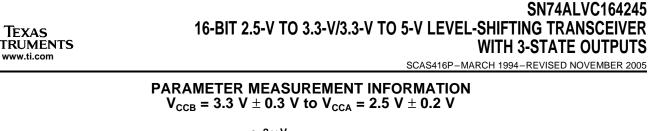
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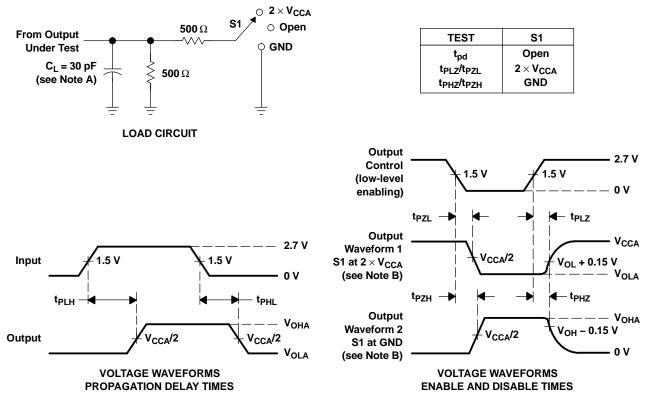


- NOTES: A. C<sub>1</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR $\leq$ 10 MHz, Z<sub>0</sub> = 50  $\Omega$ , t<sub>f</sub> $\leq$ 2 ns, t<sub>f</sub> $\leq$ 2 ns.

  - D. The outputs are measured one at a time, with one transition per measurement.
  - E.  $t_{PL7}$  and  $t_{PH7}$  are the same as  $t_{dis}$ .
  - F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
  - G. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.

#### Figure 1. Load Circuit and Voltage Waveforms





NOTES: A. CL includes probe and jig capacitance.

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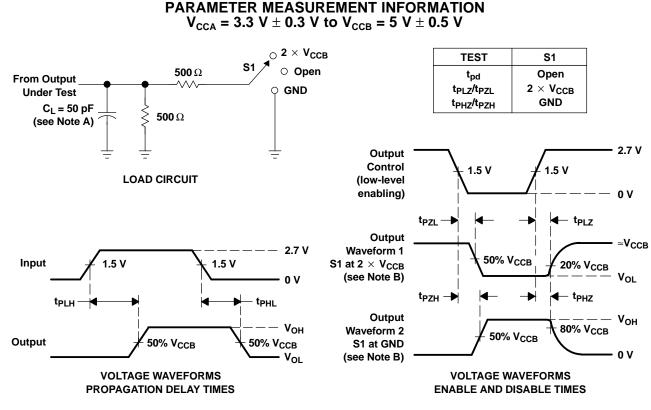
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- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>r</sub>  $\leq$  2 ns, t<sub>r</sub>  $\leq$  2 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

#### Figure 2. Load Circuit and Voltage Waveforms



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NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>0</sub> = 50  $\Omega$ , t<sub>r</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.

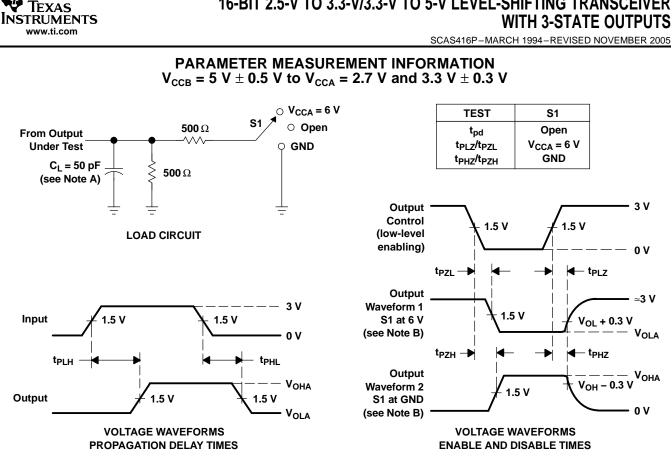
D. The outputs are measured one at a time, with one transition per measurement.

E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .

F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.

G. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.

#### Figure 3. Load Circuit and Voltage Waveforms



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

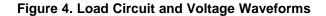
B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.

- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>r</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.

E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .

F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .

G. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.



## SN74ALVC164245 16-BIT 2.5-V TO 3.3-V/3.3-V TO 5-V LEVEL-SHIFTING TRANSCEIVER

W TEXAS

#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
74ALVC164245DGGRE4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVC164245DGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVC164245DGGTE4	ACTIVE	TSSOP	DGG	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVC164245DLRG4	ACTIVE	SSOP	DL	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ALVC164245GRDR	ACTIVE	LFBGA	GRD	54	1000	TBD	SNPB	Level-1-240C-UNLIM
74ALVC164245ZQLR	ACTIVE	VFBGA	ZQL	56	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM
74ALVC164245ZRDR	ACTIVE	LFBGA	ZRD	54	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM
SN74ALVC164245DGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVC164245DGGT	ACTIVE	TSSOP	DGG	48	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVC164245DL	ACTIVE	SSOP	DL	48	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVC164245DLR	ACTIVE	SSOP	DL	48	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ALVC164245KR	ACTIVE	VFBGA	GQL	56	1000	TBD	SNPB	Level-1-240C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

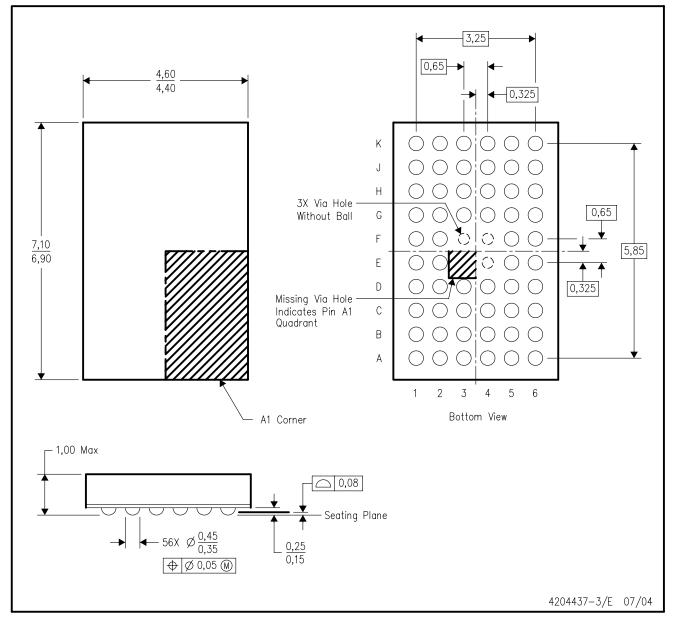
<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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ZQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Falls within JEDEC MO-225 variation BA.

D. This package is lead-free. Refer to the 56 GQL package (drawing 4200583) for tin-lead (SnPb).



GRD (R-PBGA-N54)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

 $\bigcirc$  Falls within JEDEC MO-205 variation DD.

D. This package is tin-lead (SnPb). Refer to the 54 ZRD package (drawing 4204760) for lead-free.



ZRD (R-PBGA-N54)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

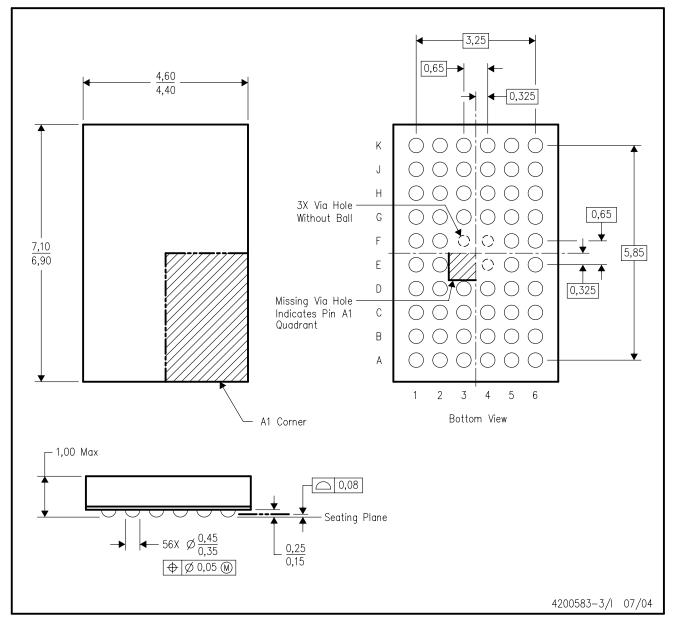
Falls within JEDEC MO-205 variation DD.

D. This package is lead-free. Refer to the 54 GRD package (drawing 4204759) for tin-lead (SnPb).



GQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Falls within JEDEC MO-225 variation BA.

D. This package is tin-lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead-free.



# **MECHANICAL DATA**

MSSO001C - JANUARY 1995 - REVISED DECEMBER 2001

#### PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN

DL (R-PDSO-G\*\*)



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118



# **MECHANICAL DATA**

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

#### DGG (R-PDSO-G\*\*)

### PLASTIC SMALL-OUTLINE PACKAGE

**48 PINS SHOWN** 



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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